

# Real-Time Systems & Fault Tolerance

Flávia Maristela

Instituto Federal da Bahia  
Especialização em Computação Distribuída e Ubíqua (ECDU)

Salvador, Outubro de 2013



# Schedule

- ➊ Motivation
- ➋ Saving Energy
- ➌ Energy Savings and Real-Time Systems
- ➍ Energy and Fault



## ① Motivation

## ② Saving Energy

## ③ Energy Savings and Real-Time Systems

## ④ Energy and Fault

## Computers in the past

- In the past 50 years designers believed that computers had to be “fast, small and cheap”
- Microprocessor design used to focus on:
  - ① improving throughput
  - ② decreasing chips area
- Recently, “lower power” was added  $\Rightarrow$  significantly complicated the whole picture
  - ① portable personal computing
  - ② communication devices
  - ③ reliability issues
  - ④ ubiquitous and pervasive applications



## Mobile Devices and Energy

- The advent of mobile computing motivated the focus to be changed to providing more power conscious solutions.
- Today, many real-time systems are battery-operated embedded devices  $\Rightarrow$  restricted energy budgets.

## Power Management: Why and What?

① Motivation

② Saving Energy

③ Energy Savings and Real-Time Systems

④ Energy and Fault

## Power Management: Why and What?

- Battery operated: most mobile systems as Laptops, PDAs and Cell phones
- Heating: for complex Servers as the ones based on multiprocessors
- Power Aware: maintain QoS, reduce energy

## Power Management: Why and What?

The peak computing rate needed is much higher than the average throughput that must be sustained

High performance is needed only for a small fraction of time, while for the rest of time, a low-power processor would suffice.



## Power Management: How?

- Power off un-used parts: LCD, disk for Laptop
- Gracefully reduce the performance
  - CPU: dynamic power  $P_d = C_{ef}V_{dd}^2f$  [Chandrakasan-1992, Burd-1995]
    - $C_{ef}$ : switch capacitance
    - $V_{dd}$ : supply voltage
    - $f$ : processor frequency  $\Rightarrow$  linear to  $V_{dd}$



- Common Processors: static power + dynamic power



## Energy Model

- Common Processors: static power + dynamic power

- Power consumed by microprocessors can be stated as follows:

$$P \propto C_{ef} V^2 f, \quad (1)$$

where  $C_{ef}$  is the switch capacitance;  
 $V$  is the supply voltage; and  
 $f$  is the maximum frequency.



- Most used techniques for providing power reduction:
  - Dynamic Frequency Scaling (DFS)
  - Dynamic Voltage Scaling (DVS)
  - Dynamic Power Management (DPM)

- Most used techniques for providing power reduction:
  - Dynamic Frequency Scaling (DFS)
  - Dynamic Voltage Scaling (DVS)
  - Dynamic Power Management (DPM)
  - **Dynamic Power and Frequency Scaling (DVFS)**

## Frequency Scaling

saves energy by reducing frequency without changing supply voltage

- At maximum frequency  $f_{max}$ , energy consumption is:

$$E = C_{ef} V_{max}^2 f_{max} \quad (2)$$

- We assume  $f_{max} = 1$
- At frequency  $f < f_{max}$ , the power dissipation is

$$P = C_{ef} V_{max}^2 f \quad (3)$$

## Voltage Scaling

reduces the supply voltage for lower frequencies to save energy

- Standard technique for managing the power consumption.
- Several energy saving approaches are based on Dynamic Voltage Scaling - DVS
- DVS can reduce power consumption at least quadratically at the expense of linearly increasing delay (reducing speed).

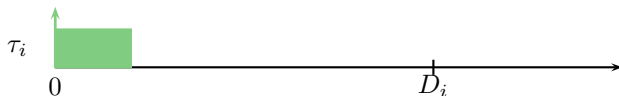


Considers that frequency and voltage almost always varies proportionally

- Assume that the supply voltage  $V_{max} = 1$ .
- Thus, for frequency  $f$ , the supply voltage is given by  $V = V_{max} \cdot f$
- At voltage  $V < V_{max}$ , the power dissipation is

$$P = C_{ef} V^2 f \quad (4)$$

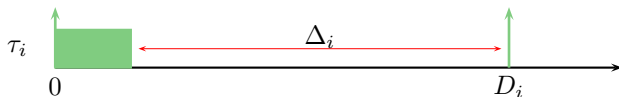
- For real-time systems, scaling down processing frequency (speed) may cause a deadline miss



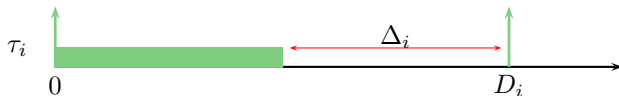
- Task executed with lower supply voltage



- The idea is to use slack  $\Delta$  to save energy



- Task executed with lower voltage supply



- Basically, there are two kinds of slack: *static* and *dynamic*
  - Static: the difference between deadline and execution cost of tasks
  - Dynamic: results at runtime when a task consumes less than its worst-case execution time
  - Recent studies<sup>1</sup> show that DVFS has a direct impact on transient fault rates.

---

<sup>1</sup>The effects of Energy Management on Reliability in Real-Time Embedded Systems

- The idea to deal with transient faults and power consumption is very simple:
  - Exploit the available slack to schedule a recovery task
  - Use the “remaining” slack for power management
- This approach has been called *Reliability Aware Power Management* and has been extensively used explored for uniprocessor systems.

- Energy consumption and fault occurrence are co-related:
  - As the energy consumption increases so does the temperature and hence the frequency (likelihood) of fault occurrence.
  - An increment in fault occurrence causes re-execution of the task (or the execution of an alternative version) leading to higher energy consumption.
  - Also, in order to achieve energy minimization, less redundancy (time or space) should be deployed (as it add to the overheads).
  - However, most of the time, the higher the redundancy the better is the fault tolerance of the system.
- Thus, there is a trade-off which should be accurately tuned to provide better performance both in terms of energy and fault.

## Frequency Scaling and Fault Occurrence

- When supply voltage is fixed, the fault rate in circuits decrease linearly when frequency reduces <sup>2</sup>
- For frequency scaling with fixed supply voltage the average fault rate can be modeled as:

$$\lambda(f, V) = \lambda(f) = \lambda_0 f^b \quad (5)$$

where  $\lambda_0$  is the average fault rate and  $b(> 0)$  is a constant. For  $b = 1$  the fault rate is linearly increasing with the frequency

---

<sup>2</sup>Modeling the effects of technology trends on the soft error rate of combinational logic

## Voltage Scaling and Fault Occurrence

- For technologies which have different supply voltages, the fault rate increases exponentially when supply voltage decreases<sup>3</sup>
- For frequency  $f$  and voltage  $V = fV_{max} = f$ , the average fault rate is:

$$\lambda(f, V) = \lambda(f) = \lambda_0 10^{\frac{d(1-f)}{1-f_{min}}} \quad (6)$$

---

<sup>3</sup>Trends in electronic reliability: effects of terrestrial cosmic rays 